Search Notes

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Applicant(s)/Patent under Reexamination

OONISHI ET AL.

10/821,923

Examiner

Art Unit

Lorna M. Douyon

1751

| | SEAR | CHED | |
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| Class | Subclass | Date | Examiner |
| 510 | 201 | 2/19/2007 | LMD |
| 510 | 202 | 2/19/2007 | LMD |
| 510 | 203 | 2/19/2007 | LMD |
| 510 | 213 | 2/19/2007 | LMD |
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